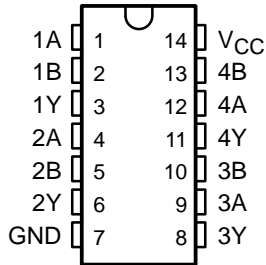


SN54AC00, SN74AC00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

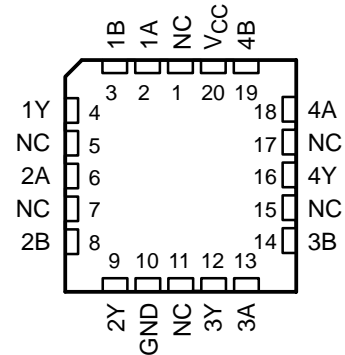
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- 2-V to 6-V V_{CC} Operation
- Inputs Accept Voltages to 6 V
- Max t_{pd} of 7 ns at 5 V

SN54AC00 . . . J OR W PACKAGE
SN74AC00 . . . D, DB, N, NS, OR PW PACKAGE
(TOP VIEW)



SN54AC00 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

description/ordering information

The 'AC00 devices contain four independent 2-input NAND gates. Each gate performs the Boolean function of $Y = \overline{A \cdot B}$ or $Y = \overline{\overline{A} + \overline{B}}$ in positive logic.

ORDERING INFORMATION

T_A	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	PDIP – N	Tube	SN74AC00N	SN74AC00N
	SOIC – D	Tube	SN74AC00D	AC00
		Tape and reel	SN74AC00DR	
	SOP – NS	Tape and reel	SN74AC00NSR	AC00
	SSOP – DB	Tape and reel	SN74AC00DBR	AC00
	TSSOP – PW	Tape and reel	SN74AC00PWR	AC00
-55°C to 125°C	CDIP – J	Tube	SNJ54AC00J	SNJ54AC00J
	CFP – W	Tube	SNJ54AC00W	SNJ54AC00W
	LCCC – FK	Tube	SNJ54AC00FK	SNJ54AC00FK

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE
(each gate)

INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H



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SN54AC00, SN74AC00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V_{CC} or GND	±200 mA
Package thermal impedance, θ_{JA} (see Note 2):	
D package	86°C/W
DB package	96°C/W
N package	80°C/W
NS package	76°C/W
PW package	113°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		SN54AC00		SN74AC00		UNIT
		MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage	2	6	2	6	V
V_{IH}	High-level input voltage	$V_{CC} = 3$ V		2.1		V
		$V_{CC} = 4.5$ V		3.15		
		$V_{CC} = 5.5$ V		3.85		
V_{IL}	Low-level input voltage	$V_{CC} = 3$ V		0.9		V
		$V_{CC} = 4.5$ V		1.35		
		$V_{CC} = 5.5$ V		1.65		
V_I	Input voltage	0	V_{CC}	0	V_{CC}	V
V_O	Output voltage	0	V_{CC}	0	V_{CC}	V
I_{OH}	High-level output current	$V_{CC} = 3$ V		–12		mA
		$V_{CC} = 4.5$ V		–24		
		$V_{CC} = 5.5$ V		–24		
I_{OL}	Low-level output current	$V_{CC} = 3$ V		12		mA
		$V_{CC} = 4.5$ V		24		
		$V_{CC} = 5.5$ V		24		
$\Delta t/\Delta v$	Input transition rise or fall rate	8		8		ns/V
T_A	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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SN54AC00, SN74AC00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			SN54AC00		SN74AC00		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	I _{OH} = -50 μA	3 V	2.9			2.9		2.9		V
		4.5 V	4.4			4.4		4.4		
		5.5 V	5.4			5.4		5.4		
	I _{OH} = -12 mA	3 V	2.56			2.4		2.46		
		4.5 V	3.86			3.7		3.76		
	I _{OH} = -24 mA	4.5 V	3.86			4.7		4.76		
		5.5 V	4.86			4.7		4.76		
I _{OH} = -50 mA†	5.5 V				3.85					
I _{OH} = -75 mA†	5.5 V						3.85			
V _{OL}	I _{OL} = 50 μA	3 V	0.002		0.1	0.1		0.1		V
		4.5 V	0.001		0.1	0.1		0.1		
		5.5 V	0.001		0.1	0.1		0.1		
	I _{OL} = 12 mA	3 V			0.36	0.5		0.44		
		4.5 V			0.36	0.5		0.44		
	I _{OL} = 24 mA	4.5 V			0.36	0.5		0.44		
		5.5 V			0.36	0.5		0.44		
I _{OL} = 50 mA†	5.5 V				1.65					
I _{OL} = 75 mA†	5.5 V						1.65			
I _I	V _I = V _{CC} or GND	5.5 V			±0.1	±1		±1		μA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V			2	40		20		μA
C _i	V _I = V _{CC} or GND	5 V			2.6					pF

† Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T _A = 25°C			SN54AC00		SN74AC00		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	A or B	Y	2	7	9.5	1	11	2	10	ns
t _{PHL}			1.5	5.5	8	1	9	1	8.5	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T _A = 25°C			SN54AC00		SN74AC00		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	A or B	Y	1.5	6	8	1	8.5	1.5	8.5	ns
t _{PHL}			1.5	4.5	6.5	1	7	1	7	

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	C _L = 50 pF, f = 1 MHz	40	pF

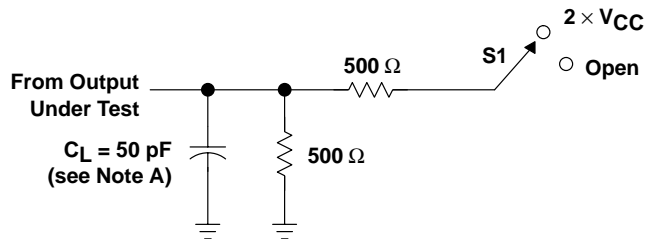


SN54AC00, SN74AC00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

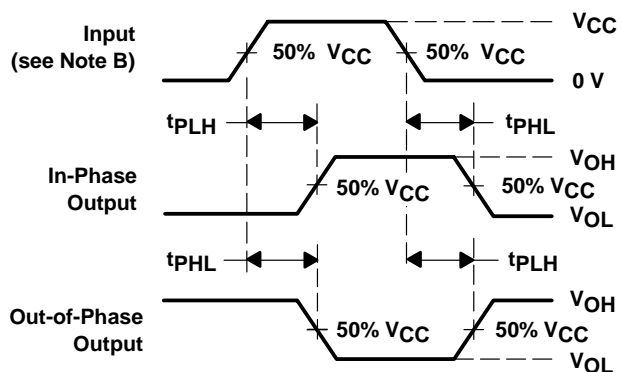
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PARAMETER MEASUREMENT INFORMATION

TEST	S1
t_{PLH}/t_{PHL}	Open



LOAD CIRCUIT



VOLTAGE WAVEFORMS

- NOTES: A. C_L includes probe and jig capacitance.
 B. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 2.5 \text{ ns}$, $t_f \leq 2.5 \text{ ns}$.
 C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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